Area_based_analysis

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- 1. Data Loading and Preprocessing
- 1.1 Edge Data
- 1.2 Surface Data
- 1.3 Calibration Wafer Data
- 2. Surface Area Distribution Analysis

Surface Analysis: Particle Area Distribution

Solid lines: observed data, Dotted lines: fitted curves, Black line: overall average

8

1000 block

1000 clock

1

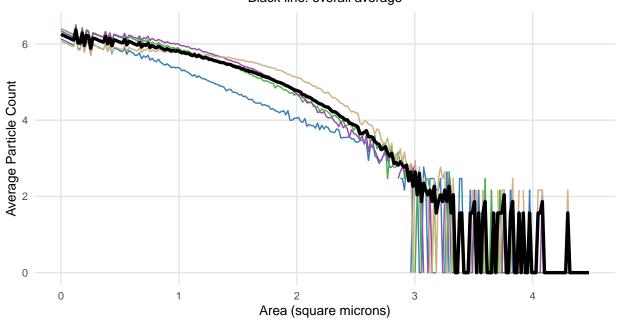
Trial 8 9 10 11

Table 1: PCL and Slope Statistics for Surface Analysis

Trial	slope	intercept	PCL
8	-1.448641	8.027225	347704.0
9	-1.639517	8.699482	202359.9
10	-1.757251	8.866243	111050.4
11	-1.507035	8.699415	592291.9

Surface Analysis: Binned Particle Size Distribution

Particles binned by area thresholds Black line: overall average

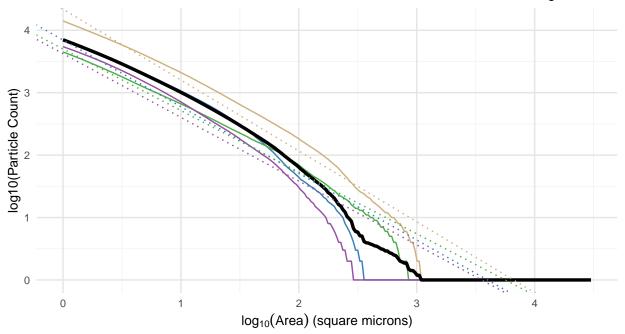


- 8 --- 9 ---- 10 ---- 11

3. Edge Area Distribution Analysis

Edge Analysis: Particle Area Distribution

Solid lines: observed data, Dotted lines: fitted curves, Black line: overall average



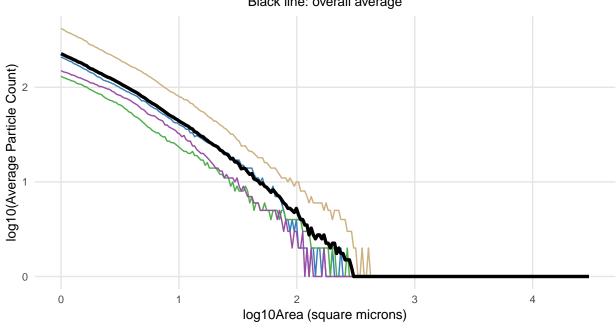
Trial 8 9 10 11

Table 2: Edge Analysis Summary Statistics

Trial	PCL	slope
8	3983.212	-1.0674936
9	5625.376	-0.9868734
10	3554.201	-1.0209514
11	6622.308	-1.1352296

Edge Analysis: Binned Particle Size Distribution

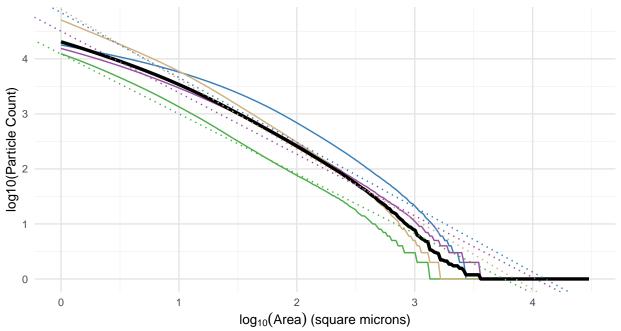
Particles binned by logarithmic area thresholds Black line: overall average



4. Calibration Wafer Analysis

Calibration Wafer Analysis: Particle Area Distribution

Solid lines: observed data, Dotted lines: fitted curves, Black line: overall average



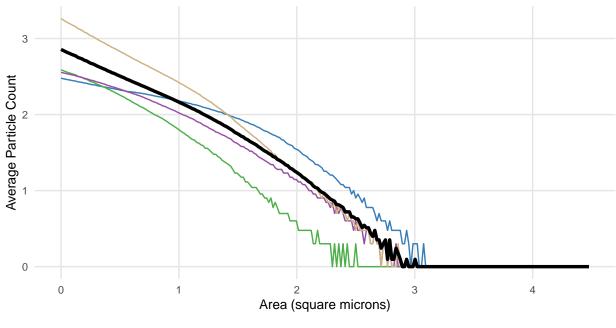
Trial 8 9 10 11

Table 3: Calibration Wafer Analysis Summary Statistics

Trial	slope	intercept	PCL
8	-1.178606	4.839839	12776.409
9	-1.087750	4.087671	5726.823
10	-1.118686	4.502859	10595.725
11	-1.272620	4.901119	7099.086

Calibration Wafer Analysis: Binned Particle Size Distribution

Particles binned by logarithmic area thresholds
Black line: overall average

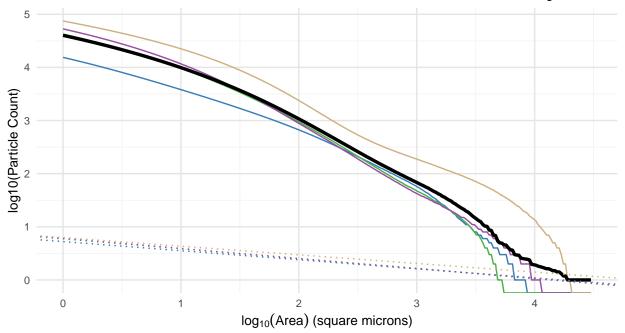


- 8 -- 9 -- 10 -- 11

5. Edge Model Analysis

Edge Model Analysis: Particle Area Distribution

Solid lines: modeled data, Dotted lines: fitted curves, Black line: overall average



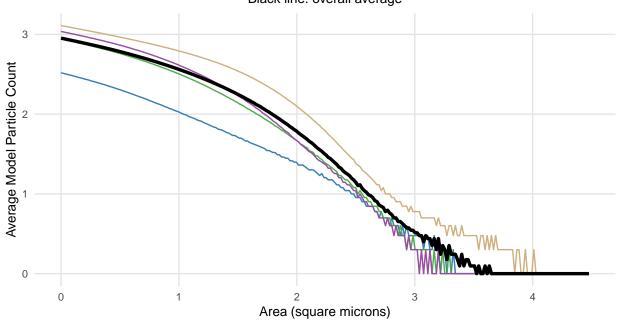
Trial 8 9 10 11

Table 4: Edge Model Analysis Summary Statistics

slope	PCL	Trial
-0.1707850	16841.01	8
-0.1859847	14480.80	9
-0.1888140	13769.60	10
-0.1623550	81903.41	11

Edge Model Analysis: Binned Particle Size Distribution

Particles binned by area thresholds Black line: overall average

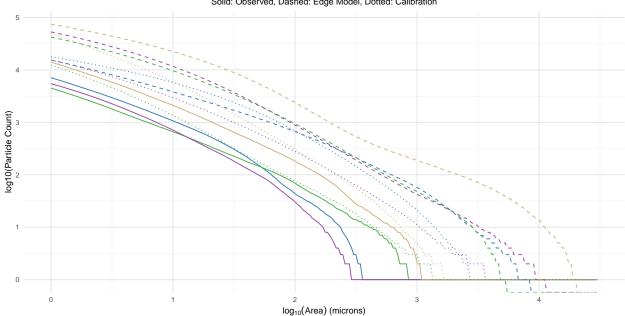


- 8 --- 9 ---- 10 ---- 11

6. Combined Analysis and Comparison

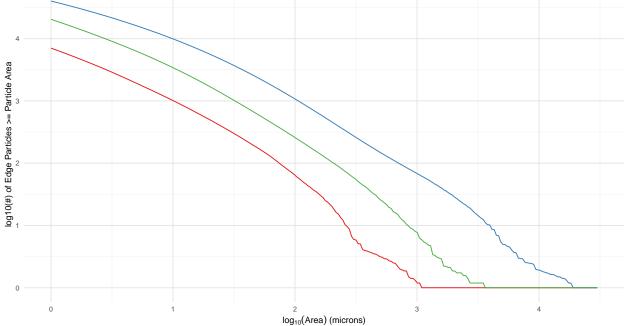
Distribution of Particles by Trial

Solid: Observed, Dashed: Edge Model, Dotted: Calibration

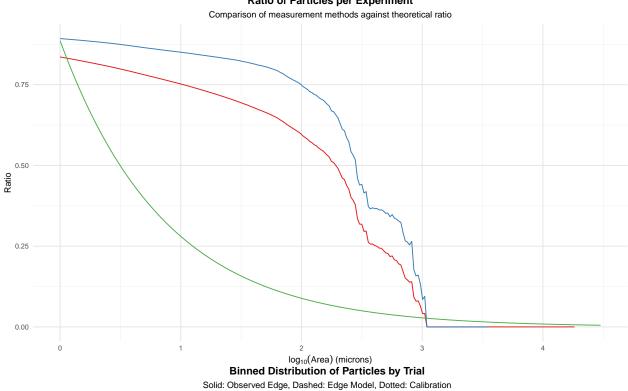


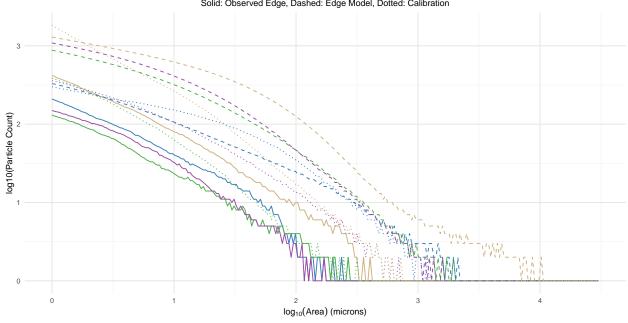
Trial — 8 — 9 — 10 — 11

Distribution of Particles by Model Red: Observed Edge Counts, Blue: Modeled Edge Counts, Green: Observed Calibration Counts

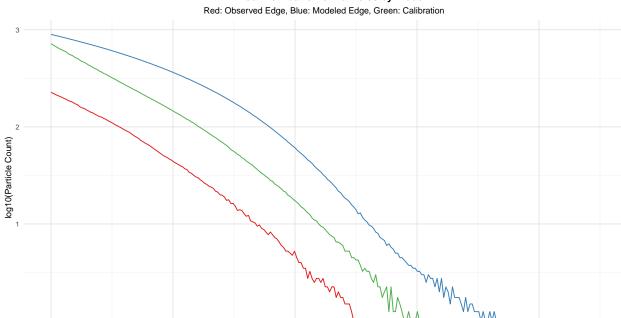




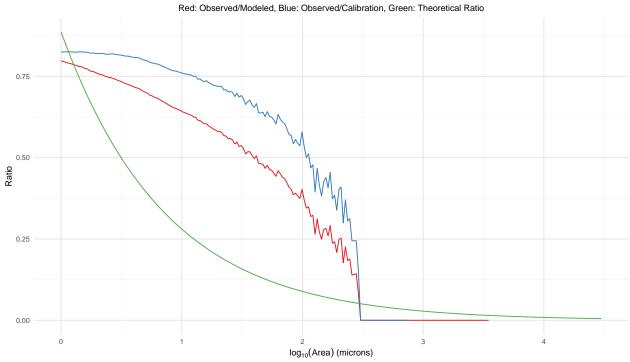




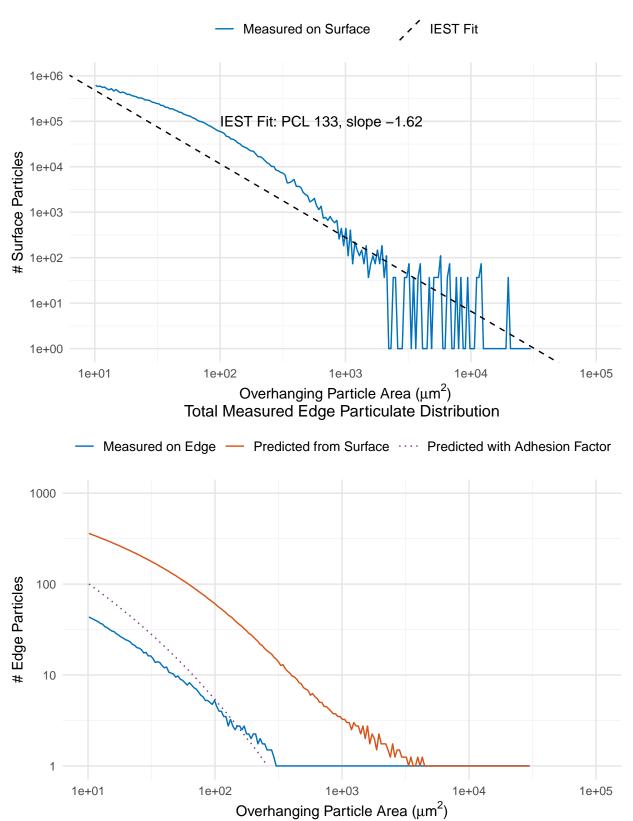
Binned Distribution of Particles by Model



log₁₀(Area) (microns) Ratio of Binned Particles per Experiment

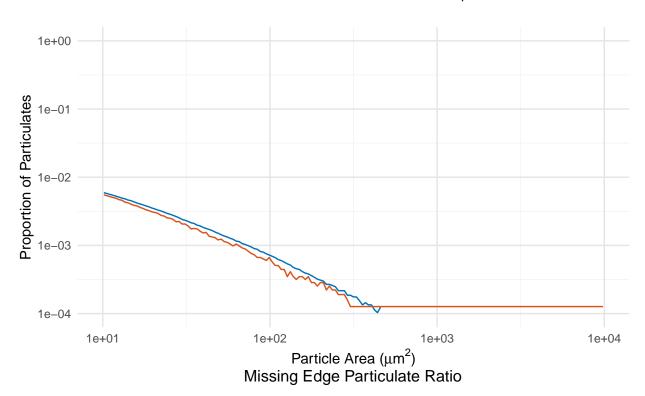


Total Measured Surface Particulate Distribution



Normalized Edge Particulate Distributions

Calibration Mask
 Etched Samples



- - 1/diam. Fitted Curve — Ratio

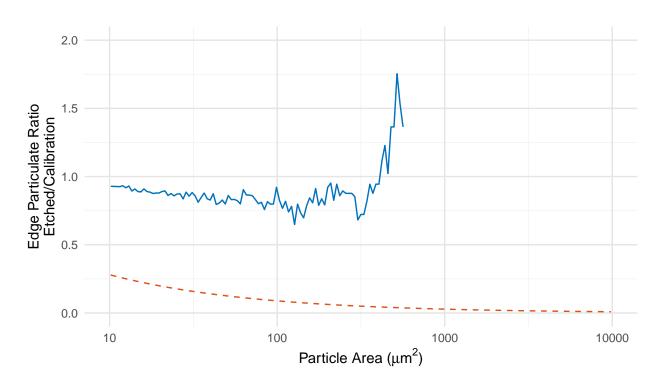


Figure 15: Etched Samples Comparison

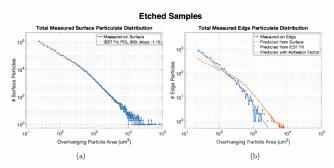


Figure 15. (a) Total surface particulate distribution detected on the etched samples, and a fit to the IEST distribution (b) Total edge particulate distribution detected on the etched samples, compared to predictions from the surface.

Total Measured Surface Particulate Distributiontal Measured Edge Particulate Distribu

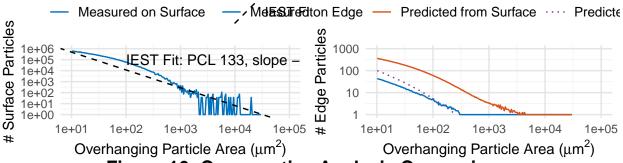


Figure 16: Comparative Analysis Comparison

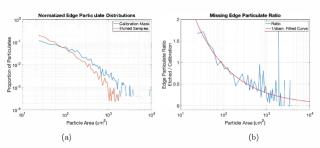


Figure 16. (a) Normalized edge particulate distributions for the calibration mask and the etched samples. Each distribution has been normalized based on the total number of edge particulates. (b) Ratio of the normalized edge distributions, representing the portion of particulates missing from the etched samples. inversely proportional to the particle diameter.

Normalized Edge Particulate Distributions

Missing Edge Particulate Ratio

